

Date Mailed: SEPTEMBER 19, 2006

Sheet 1 of 1

FORM 1449* INFORMATION DISCLOSURE STATEMENT IN AN APPLICATION (Use several sheets if necessary)	Docket Number: 14434.100USWO	Application Number: UNKNOWN
	Applicant: NAKAGAWA	
	Filing Date: CONCURRENT HEREWITH	Group Art Unit: UNKNOWN

U.S. PATENT DOCUMENTS						
EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	2003/0136964	7.24.2003	Afzali-Ardakani et al.			
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	2003-518754	2003.6.10	JP			SEE IDS
	01/47043	28.06.2001	WIPO			
	2003-258260	2003.9.12	JP			ABSTRACT
	2004-179542	2004.6.24	JP			ABSTRACT
	2005-243822	2005.9.8	JP			ABSTRACT
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)						
		Nakagawa et al., "Atomic force microscope for chemical sensing", J. Vac. Sci. Technol. B 12(3), May/June 1994, pp. 2215-2218.				

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EXAMINER /Colleen Rodgers/	DATE CONSIDERED 10/03/2008
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form for next communication to the Applicant.	